

FORM PTO-1449 LIST OF DOCUMENTS CITED BY APPLICANT		Atty. Docket No. XA-10070	Appln. No. 10/829,360
		Applicant Yuichi MATSUI	
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U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
TH	AA	5,622,888	4/22/97	Sekine et al.	438	398	
	AB	6,235,572	5/22/01	Kunitomo et al.	438	240	
	AC	6,243,255	6/5/01	Kuge et al.	361	528	
	AD	2003/0011022	1/16/03	Manabe	257	314	
	AE	6,576,928	6/10/03	Hiratani et al.	257	68	
	AF	6,673,461	1/6/04	Chazono et al.	428	469	
	AG	5,970,337	10/19/99	Nishioka	438	240	
TH	AH	2003-0151083	8/14/03	Matsui et al.	257	310	
	AI						

FOREIGN PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
TH	AJ	8-139288	5/31/96	JAPAN			abstract
	AK	2000-12796	1/14/00	JAPAN			abstract
	AL	2000-82639	3/21/00	JAPAN			abstract
	AM	2002-164516	6/7/02	JAPAN			abstract
	AN	2003-243534	8/29/03	JAPAN			abstract
TH	AO	2001-77108	3/23/01	JAPAN			abstract

OTHER (including author, title, date, pertinent pages, etc.)

TH	AP	Rosenfeld, D. et al., "Structural and morphological characterization of Nb ₂ O ₅ thin films deposited by reactive sputtering", <u>American Vacuum Society</u> , 1994, pp. 135-139.
	AQ	
	AR	

Examiner	TH - TH HO	Date Considered	Oct 2005
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.			

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U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
	BA						
	BB						
	BC						
	BD						
	BE						
	BF						
	BG						
	BH						
	BI						
FOREIGN PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
TH	BJ	5-345663	12/27/93	JAPAN			abstract
	BK	10-12043	1/16/98	JAPAN			abstract
	BL	2001-284158	10/12/01	JAPAN			abstract
	BM	8-31951	2/2/96	JAPAN			abstract
TH	BN	11-330415	11/30/99	JAPAN			abstract
	BO						
OTHER (including author, title, date, pertinent pages, etc.)							
	BP						
	BQ						
	BR						
Examiner	<i>TH - TH - H0</i>			Date Considered			<i>Oct 2005</i>
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